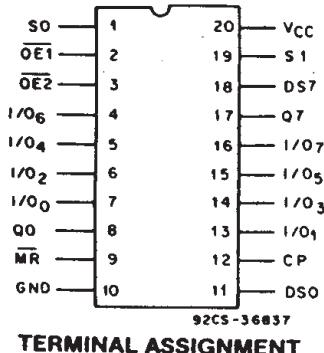




Data sheet acquired from Harris Semiconductor
SCHS288

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323



8-Input Universal Shift/Storage Register with Common Parallel I/O Pins

CD54/74AC/ACT299 - Asynchronous Reset
CD54/74AC/ACT323 - Synchronous Reset

Type Features:

- *Buffered inputs*
- *Typical propagation delay:
6 ns @ V_{cc} = 5 V, T_A = 25°C, C_L = 50 pF*

The RCA CD54/74AC299 and CD54/74AC323 and the CD54/74ACT299 and CD54/74ACT323 are 3-state, 8-input universal shift/storage registers with common parallel I/O pins. These devices use the RCA ADVANCED CMOS technology. These registers have four synchronous-operating modes controlled by the two select inputs as shown in the Mode Select (S0, S1) table. The Mode Select, the Serial Data (DS0, DS7), and the Parallel Data (I/O0 - I/O7) respond only to the LOW-TO-HIGH transition of the clock (CP) pulse. S0, S1 and Data inputs must be present one setup time prior to the positive transition of the clock.

With the CD54/74AC/ACT299, the Master Reset (MR) is an asynchronous active-LOW input. When MR is LOW, the register is cleared regardless of the status of all other inputs. With the CD54/74AC/ACT323, the Master Reset (MR) clears the register in sync with the clock input. The register can be expanded by cascading same units by tying the serial output (QO) to the serial data (DS7) input of the preceding register, and tying the serial output (Q7) to the serial data (DS0) input of the following register. Recirculating the (n x 8) bits is accomplished by tying the Q7 of the last stage to the DSO of the first stage.

The 3-state input/output (I/O) port has three modes of operation:

1. Both Output Enable (\overline{OE}_1 and \overline{OE}_2) inputs are LOW and S0 or S1 or both are LOW; the data in the register is present at the eight outputs.
2. When both S0 and S1 are HIGH, I/O terminals are in the high-impedance state but being input ports, ready for parallel data to be loaded into eight registers with one clock transition regardless of the status of \overline{OE}_1 and \overline{OE}_2 .

Family Features:

- Exceeds 2-kV ESD Protection - MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST®/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply
- $\pm 24\text{-mA}$ output drive current
 - Fanout to 15 FAST® ICs
 - Drives 50-ohm transmission lines

*FAST is a Registered Trademark of Fairchild Semiconductor Corp.

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3. Either one of the two Output Enable inputs being HIGH will force I/O terminals to be in the off state. It is noted that each I/O terminal is a 3-state output and a CMOS buffer input.

The CD74AC/ACT299 and CD74AC/ACT323 are supplied in 20-lead dual-in-line plastic packages (E suffix) and in 20-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to 70°C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 to +125°C).

The CD54AC/ACT299 and CD54AC/ACT323, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

Technical Data

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323

MODE SELECT — FUNCTION TABLE

REGISTER OPERATING MODES

FUNCTION	INPUTS							REGISTER OUTPUTS				
	MR	CP	S0	S1	DS0	DS7	I/O _n	Q0	Q1	...	Q6	Q7
Reset (Clear)	L	X*	X	X	X	X	X	L	L	...	L	L
Shift Right	H	—/—	h	I	I	X	X	L	q ₀	...	q ₅	q ₆
	H	—/—	h	I	h	X	X	H	q ₀	...	q ₅	q ₆
Shift Left	H	—/—	I	h	X	I	X	q ₁	q ₂	...	q ₇	L
	H	—/—	I	h	X	h	X	q ₁	q ₂	...	q ₇	H
Hold (do nothing)	H	—/—	I	I	X	X	X	q ₀	q ₁	...	q ₆	q ₇
Parallel Load	H	—/—	h	h	X	X	I	L	L	...	L	L
	H	—/—	h	h	X	X	h	H	H	...	H	H

*On CD54/74AC/ACT323, CP must be in transition from the LOW-to-HIGH state to Reset (Clear).

MODE SELECT — FUNCTION TABLE

3-STATE I/O PORT OPERATING MODE

FUNCTION	INPUTS					Q _n (Register)	INPUTS/OUTPUTS			
	OE1	OE2	S0	S1	Q _n (Register)		I/O ₀	...	I/O ₇	
Read Register	L	L	L	X	L H L H	L	L H L H	I/O ₀ ... I/O ₇		
	L	L	L	X		H				
	L	L	X	L		L				
	L	L	X	L		H				
Load Register	X	X	H	H	Q _n = I/O _n	I/O _n = Inputs				
Disable I/O	H	X	X	X		X	(Z)			
	X	H	X	X		X	(Z)			

H = Input voltage high level.

h = Input voltage high one set-up time prior clock transition.

L = Input voltage low level.

I = Input voltage low one set-up time prior clock transition.

q_n = Lower case letters indicate the state of the referenced output one set-up time prior clock transition.

X = Voltage level on logic status don't care.

Z = Output in high-impedance state.

= Low-to-high clock transition.

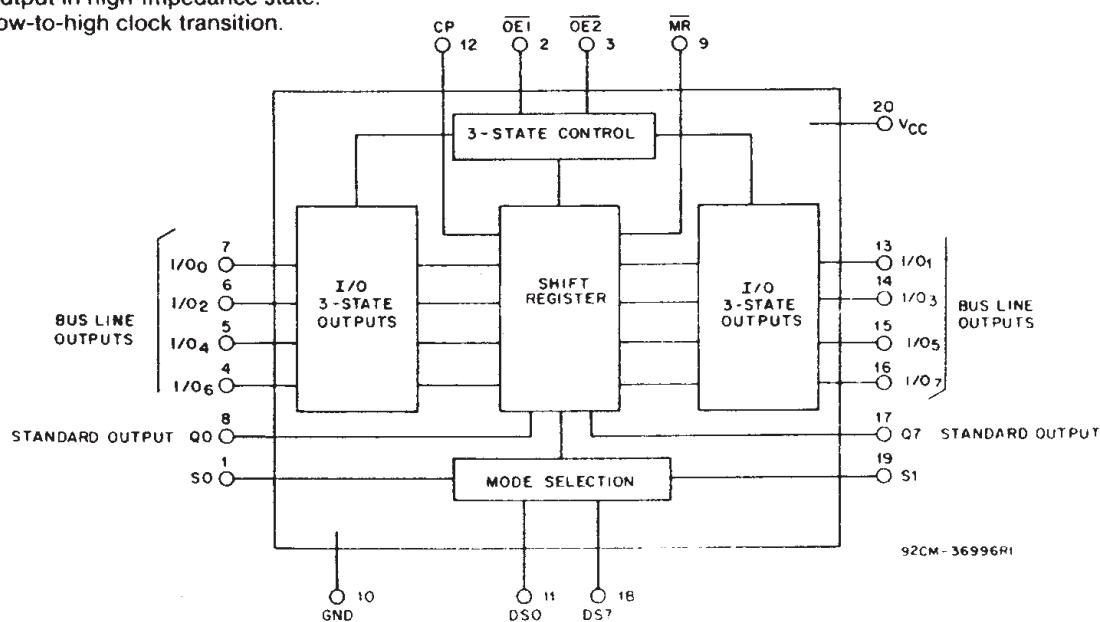


Fig. 1 - Functional diagram.

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE (V_{cc})	-0.5 to 6 V
DC INPUT DIODE CURRENT, I_{ik} (for $V_i < -0.5$ V or $V_i > V_{cc} + 0.5$ V)	± 20 mA
DC OUTPUT DIODE CURRENT, I_{ok} (for $V_o < -0.5$ V or $V_o > V_{cc} + 0.5$ V)	± 50 mA
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, I_o (for $V_o > -0.5$ V or $V_o < V_{cc} + 0.5$ V)	± 50 mA
DC V_{cc} or GROUND CURRENT (I_{cc} or I_{GND})	± 100 mA*
POWER DISSIPATION PER PACKAGE (P_D):	
For $T_A = -55$ to $+100^\circ\text{C}$ (PACKAGE TYPE E)	500 mW
For $T_A = +100$ to $+125^\circ\text{C}$ (PACKAGE TYPE E)	Derate Linearly at 8 mW/ $^\circ\text{C}$ to 300 mW
For $T_A = -55$ to $+70^\circ\text{C}$ (PACKAGE TYPE M)	400 mW
For $T_A = +70$ to $+125^\circ\text{C}$ (PACKAGE TYPE M)	Derate Linearly at 6 mW/ $^\circ\text{C}$ to 70 mW
OPERATING-TEMPERATURE RANGE (T_A)	-55 to $+125^\circ\text{C}$
STORAGE TEMPERATURE (T_{stg})	-65 to $+150^\circ\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ in. (1.59 ± 0.79 mm) from case for 10 s maximum	$+265^\circ\text{C}$
Unit inserted into PC board min. thickness $1/16$ in. (1.59 mm) with solder contacting lead tips only	$+300^\circ\text{C}$

*For up to 4 outputs per device; add ± 25 mA for each additional output.

RECOMMENDED OPERATING CONDITIONS:

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTICS	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range, V_{cc} *: (For T_A = Full Package-Temperature Range) AC Types ACT Types	1.5 4.5	5.5 5.5	V V
DC Input or Output Voltage, V_i , V_o	0	V_{cc}	V
Operating Temperature, T_A	-55	+125	$^\circ\text{C}$
Input Rise and Fall Slew Rate, dt/dv at 1.5 V to 3 V (AC Types) at 3.6 V to 5.5 V (AC Types) at 4.5 V to 5.5 V (ACT Types)	0 0 0	50 20 10	ns/V ns/V ns/V

*Unless otherwise specified, all voltages are referenced to ground.

Technical Data

**CD54/74AC299, CD54/74AC323
CD54/74ACT299, CD54/74ACT323**

STATIC ELECTRICAL CHARACTERISTICS: AC Series

CHARACTERISTICS	TEST CONDITIONS	V_{cc} (V)	AMBIENT TEMPERATURE (T_A) - °C						UNITS		
			+25		-40 to +85		-55 to +125				
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.			
High-Level Input Voltage	V_{IH}		1.5 3 5.5	1.2 2.1 3.85	— — —	1.2 2.1 3.85	— — —	1.2 2.1 3.85	— — —	V	
Low-Level Input Voltage	V_{IL}		1.5 3 5.5	— — —	0.3 0.9 1.65	— — —	0.3 0.9 1.65	— — —	0.3 0.9 1.65	V	
High-Level Output Voltage	V_{OH}	V_{IH} or V_{IL} #, *	-0.05 -0.05 -0.05 -4 -24 -75 -50	1.5 3 4.5 3 4.5 5.5 5.5	1.4 2.9 4.4 2.58 3.94 — —	— — — 2.48 3.8 3.85 —	1.4 2.9 4.4 2.4 3.7 — 3.85	— — — — — — —	1.4 2.9 4.4 2.4 3.7 — 3.85	V	
Low-Level Output Voltage	V_{OL}	V_{IH} or V_{IL} #, *	0.05 0.05 0.05 12 24 75 50	1.5 3 4.5 3 4.5 5.5 5.5	— — — 0.36 0.36 — —	0.1 0.1 0.1 0.44 0.44 1.65 —	— — — 0.44 0.44 — —	0.1 0.1 0.1 0.5 0.5 — 1.65	— — — 0.5 0.5 — 1.65		
Input Leakage Current	I_i		V_{cc} or GND	5.5	—	±0.1	—	±1	—	±1	µA
3-Stage Leakage Current	I_{oZ}		V_{IH} or V_{IL} $V_o = V_{cc}$ or GND	5.5	—	±0.5	—	±5	—	±10	µA
Quiescent Supply Current, MSI	I_{cc}		V_{cc} or GND	0	5.5	—	8	—	80	—	160

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323

STATIC ELECTRICAL CHARACTERISTICS: ACT Series

CHARACTERISTICS	TEST CONDITIONS V_i (V)	I_o (mA)	V_{cc} (V)	AMBIENT TEMPERATURE (T_A) - °C						UNITS	
				+25		-40 to +85		-55 to +125			
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
High-Level Input Voltage	V_{IH}		4.5 to 5.5	2	—	2	—	2	—	V	
Low-Level Input Voltage	V_{IL}		4.5 to 5.5	—	0.8	—	0.8	—	0.8	V	
High-Level Output Voltage	V_{OH}	#,* { V_{IH} or V_{IL} }	-0.05	4.5	4.4	—	4.4	—	4.4	V	
			-24	4.5	3.94	—	3.8	—	3.7		
			-75	5.5	—	—	3.85	—	—		
			-50	5.5	—	—	—	—	3.85		
Low-Level Output Voltage	V_{OL}	#,* { V_{IH} or V_{IL} }	0.05	4.5	—	0.1	—	0.1	—	V	
			24	4.5	—	0.36	—	0.44	—		
			75	5.5	—	—	—	1.65	—		
			50	5.5	—	—	—	—	1.65		
Input Leakage Current	I_i	V_{cc} or GND	5.5	—	±0.1	—	±1	—	±1	μA	
3-State Leakage Current	I_{oZ}	V_{IH} or V_{IL} V_o V_{cc} or GND	5.5	—	±0.5	—	±5	—	±10	μA	
Quiescent Supply Current, MSI	I_{cc}	V_{cc} or GND	0	5.5	—	8	—	80	—	160	μA
Additional Quiescent Supply Current per Input Pin TTL Inputs High 1 Unit Load	ΔI_{cc}	$V_{cc}-2.1$	4.5 to 5.5	—	2.4	—	2.8	—	3	mA	

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

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ACT INPUT LOADING TABLE

INPUT	UNIT LOADS*	
	299	323
S1, S0, $\overline{OE1}$, $\overline{OE2}$	0.83	0.83
I/O ₀ - I/O ₇ , CP, DS0, DS7	0.67	0.67
MR	1.33	0.67

*Unit load is ΔI_{cc} limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

Technical Data

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323

PREREQUISITE FOR SWITCHING: AC Series

CHARACTERISTICS	SYMBOL	V_{CC} (V)	AMBIENT TEMPERATURE (T_A) - °C				UNITS	
			-40 to +85		-55 to +125			
			MIN.	MAX.	MIN.	MAX.		
Setup Time S1, S0, to CP	t_{SU}	1.5 3.3* 5†	99 11.1 7.9	— — —	113 12.6 9	— — —	ns	
Hold Time S1, S0 to CP	t_H	1.5 3.3 5	0 0 0	— — —	0 0 0	— — —	ns	
Setup Time (I/O)n, DS0, DS7 to CP	t_{SU}	1.5 3.3 5	49 5.5 3.9	— — —	56 6.3 4.5	— — —	ns	
Hold Time (I/O)n, DS0, DS7 to CP	t_{SU}	1.5 3.3 5	0 0 0	— — —	0 0 0	— — —	ns	
Setup Time MR to CP (323)	t_{SU}	1.5 3.3 5	61 6.8 4.8	— — —	69 7.8 5.5	— — —	ns	
Hold Time MR to CP (323)	t_H	1.5 3.3 5	0 0 0	— — —	0 0 0	— — —	ns	
Maximum CP Frequency	f_{MAX}	1.5 3.3 5	9 78 108	— — —	8 68 95	— — —	MHz	
CP Pulse Width	t_W	1.5 3.3 5	57 6.4 4.6	— — —	65 7.3 5.2	— — —	ns	
MR Pulse Width	t_W	1.5 3.3 5	55 6.1 4.4	— — —	63 7 5	— — —	ns	
Recovery Time MR to CP 299	t_{REC}	1.5 3.3 5	55 6.1 4.4	— — —	63 7 5	— — —	ns	

*3.3 V: min. is @ 3 V
†5 V: min is @ 4.5 V

**CD54/74AC299, CD54/74AC323
CD54/74ACT299, CD54/74ACT323**
SWITCHING CHARACTERISTICS: AC Series; $t_r, t_f = 3 \text{ ns}$, $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	V_{CC} (V)	AMBIENT TEMPERATURE (T_A) - °C				UNITS	
			-40 to +85		-55 to +125			
			MIN.	MAX.	MIN.	MAX.		
Propagation Delays: CP to Q0, Q7	t_{PLH} t_{PHL}	1.5 3.3* 5†	— 4.7 3.3	147 16.5 11.7	— 4.5 3.2	162 18.1 12.9	ns	
CP to (I/O)n	t_{PLH} t_{PHL}	1.5 3.3 5	— 4.9 3.5	154 17.2 12.3	— 4.7 3.4	169 18.9 13.5	ns	
MR to Q0, Q7 (299 only)	t_{PLH} t_{PHL}	1.5 3.3 5	— 4 2.9	127 14.3 10.2	— 3.9 2.8	140 15.7 11.2	ns	
MR to (I/O)n	t_{PLH} t_{PHL}	1.5 3.3 5	— 5 3.6	158 17.7 12.6	— 4.9 3.5	174 19.5 13.9	ns	
Enable and Disable Times	t_{PZL} t_{PZH} t_{PLZ} t_{PHZ}	1.5 3.3 5	— 5.8 3.8	169 20.4 13.5	— 5.6 3.7	186 22.4 14.9	ns	
Power Dissipation Capacitance	$C_{PD}\$$	—	280 Typ.		280 Typ.		pF	
Input Capacitance	C_I	—	—	10	—	10	pF	
3-State Output Capacitance	C_O	—	—	15	—	15	pF	

*3.3 V: min. is @ 3.6 V
max. is @ 3 V†5 V: min. is @ 5.5 V
max. is @ 4.5 V§ C_{PD} is used to determine the dynamic power consumption, per function.

$$P_D = C_{PD}V_{CC}^2 f_i + \sum (C_L V_{CC}^2 f_o) \text{ where } f_i = \text{input frequency}$$

$$f_o = \text{output frequency}$$

$$C_L = \text{output load capacitance}$$

$$V_{CC} = \text{supply voltage}$$

PREREQUISITE FOR SWITCHING: ACT Series

CHARACTERISTICS	SYMBOL	V_{CC} (V)	AMBIENT TEMPERATURE (T_A) - °C				UNITS	
			-40 to +85		-55 to +125			
			MIN.	MAX.	MIN.	MAX.		
Setup Time S1, S0 to CP	t_{SU}	5*	7.9	—	9	—	ns	
Hold Time S1, S0 to CP	t_H	5	0	—	0	—	ns	
Setup Time (I/O)n, DS0, DS7 to CP	t_{SU}	5	3.9	—	4.5	—	ns	
Hold Time (I/O)n, DS0, DS7 to CP	t_H	5	0	—	0	—	ns	
Setup Time MR to CP (323)	t_{SU}	5*	4.8	—	5.5	—	ns	
Hold Time MR to CP (323)	t_H	5	0	—	0	—	ns	
Maximum CP Frequency	f_{max}	5	103	—	90	—	MHz	
CP Pulse Width	t_w	5	4.8	—	5.5	—	ns	
MR Pulse Width	t_w	5	4.4	—	5	—	ns	
Recovery Time MR to CP (299)	t_{REC}	5	4.4	—	5	—	ns	

*5 V: min. is @ 4.5 V

Technical Data

CD54/74AC299, CD54/74AC323 CD54/74ACT299, CD54/74ACT323

SWITCHING CHARACTERISTICS: ACT Series; $t_r, t_f = 3 \text{ ns}$, $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	V_{CC} (V)	AMBIENT TEMPERATURE (T_A) - °C				UNITS	
			-40 to +85		-55 to +125			
			MIN.	MAX.	MIN.	MAX.		
Propagation Delays: CP to Q0, Q7	t_{PLH} t_{PHL}	5*	3.3	11.7	3.2	12.9	ns	
CP to (I/O)n	t_{PLH} t_{PHL}	5	3.7	13.2	3.6	14.5	ns	
MR to Q0, Q7 (299 only)	t_{PLH} t_{PHL}	5	3.1	11.1	3.1	12.2	ns	
MR to (I/O)n	t_{PLH} t_{PHL}	5	4.8	16.9	4.7	18.6	ns	
Enable and Disable Times	t_{PLZ} t_{PHZ} t_{PZL} t_{PZH}	5	3.8	13.5	3.7	14.9	ns	
Power Dissipation Capacitance	$C_{PD\$}$	—	280 Typ.	280 Typ.	—	—	pF	
Input Capacitance	C_I	—	—	10	—	10	pF	
3-State Output Capacitance	C_O	—	—	15	—	15	pF	

*5 V: min. is @ 5.5 V
max. is @ 4.5 V

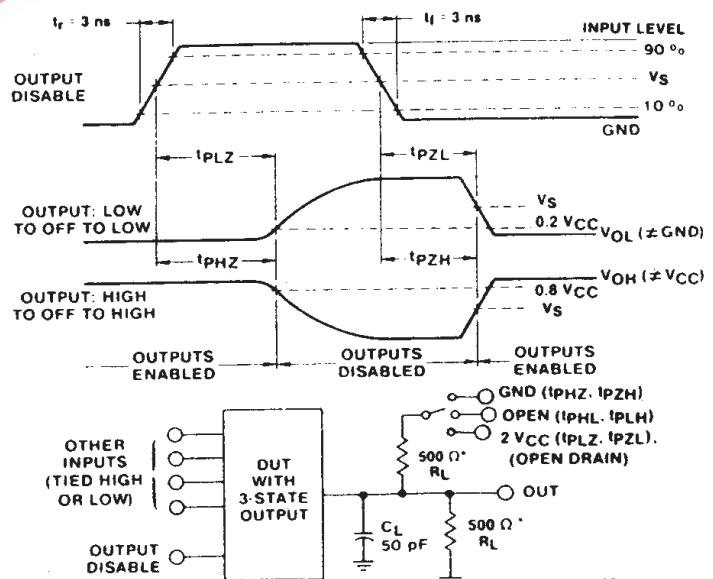
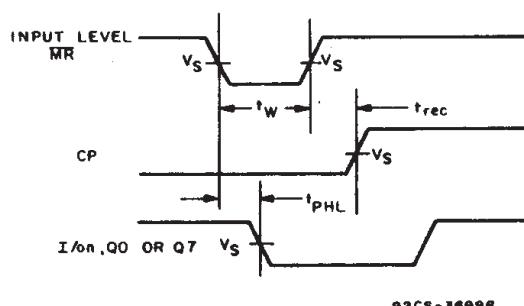
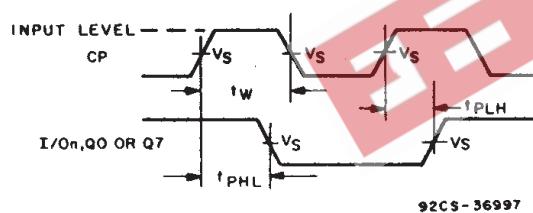
§ C_{PD} is used to determine the dynamic power consumption, per function.

$$P_D = C_{PD}V_{CC}^2 f_i + \sum (C_L V_{CC}^2 f_o) + V_{CC}\Delta I_{CC} \text{ where } f_i = \text{input frequency}$$

$$f_o = \text{output frequency}$$

$$C_L = \text{output load capacitance}$$

$$V_{CC} = \text{supply voltage.}$$



*FOR AC SERIES ONLY: WHEN $V_{CC} = 1.5 \text{ V}$, $R_L = 1 \text{ k}\Omega$

**CD54/74AC299, CD54/74AC323
CD54/74ACT299, CD54/74ACT323**

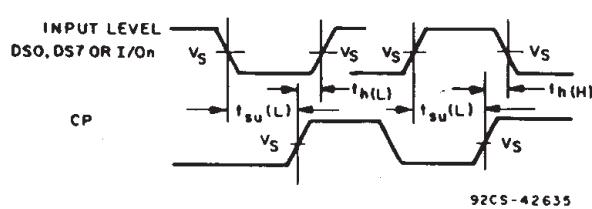
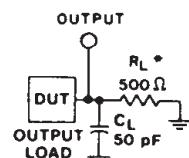


Fig. 5 - Data prerequisite times.



*FOR AC SERIES ONLY: WHEN
 $V_{CC} = 1.5 \text{ V}$, $R_L = 1 \text{ k}\Omega$

34-5 42369

Fig. 6 - Test circuit.

	CD54/74AC	CD54/74ACT
Input Level	V_{CC}	3 V
Input Switching Voltage, Vs	0.5 V_{CC}	1.5 V
Output Switching Voltage, Vs	0.5 V_{CC}	0.5 V_{CC}

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD54AC299F3A	ACTIVE	CDIP	J	20	1	TBD	Call TI	Level-NC-NC-NC
CD54ACT299F3A	ACTIVE	CDIP	J	20	1	TBD	Call TI	Level-NC-NC-NC
CD54ACT323F3A	NRND	CDIP	J	20	1	TBD	Call TI	Level-NC-NC-NC
CD74AC299M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC299M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC323M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT299M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT299M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT299M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

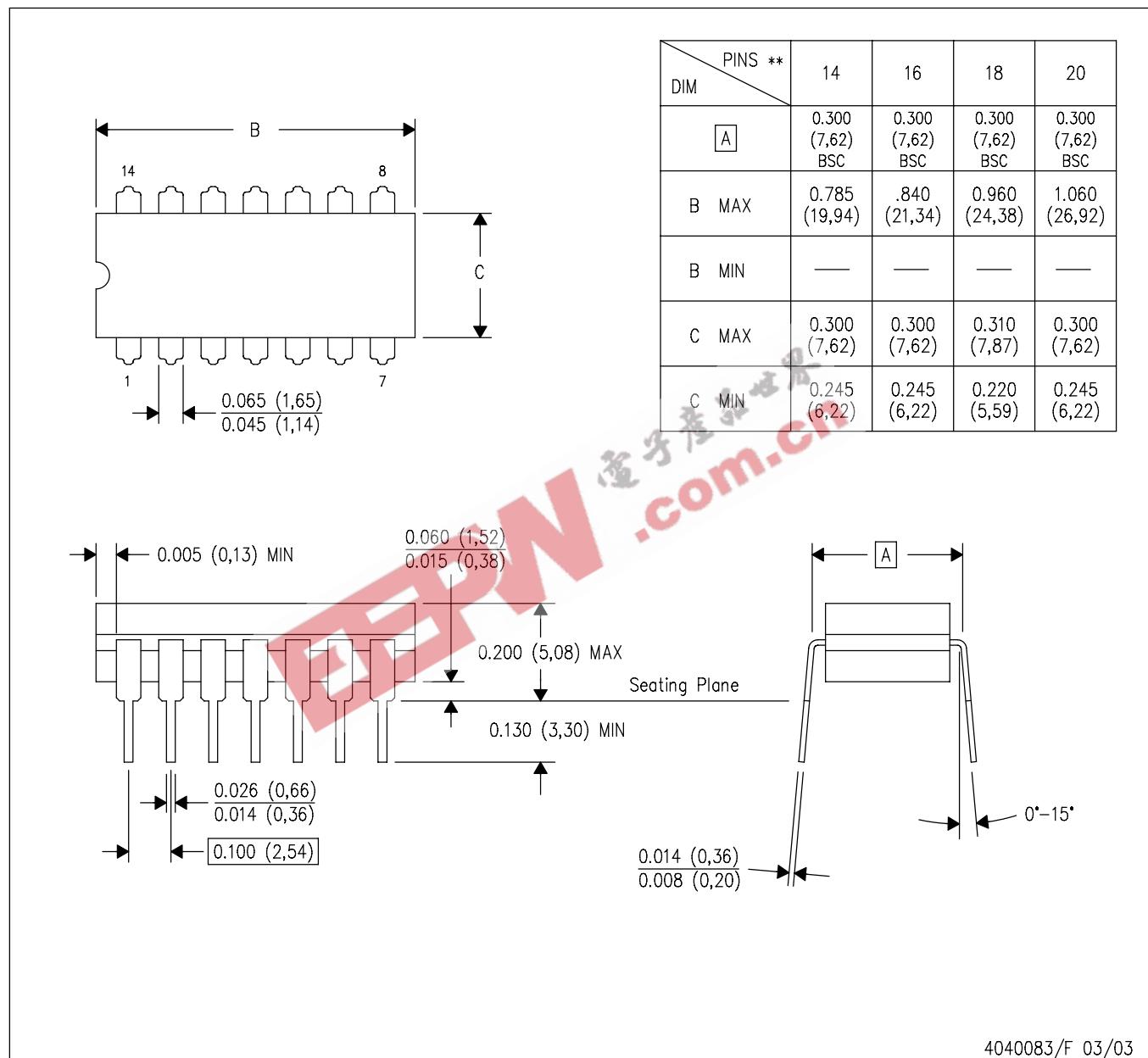
⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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J (R-GDIP-T**) CERAMIC DUAL IN-LINE PACKAGE

14 LEADS SHOWN



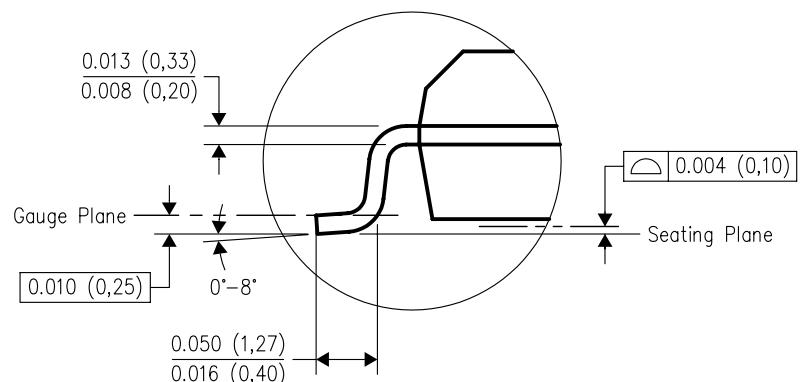
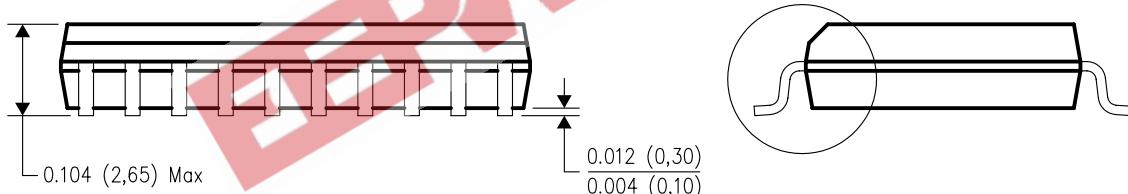
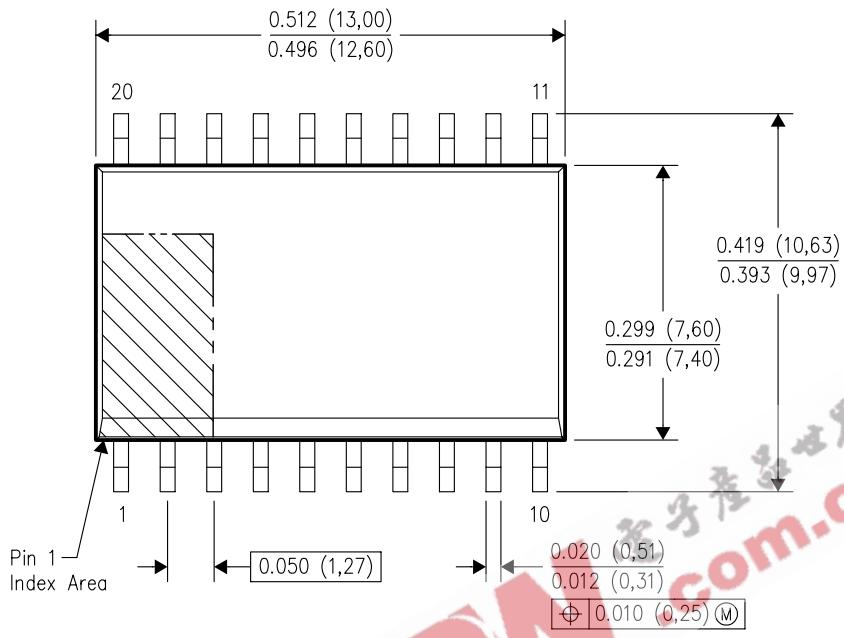
4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

MECHANICAL DATA

DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



4040000-4/F 06/2004

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Falls within JEDEC MS-013 variation AC.

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